

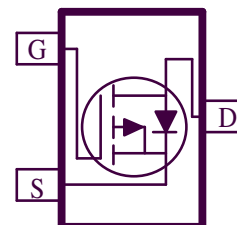
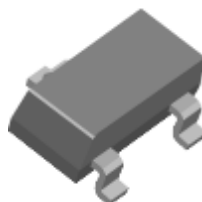


AM1331P

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $r_{DS(on)}$ and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

- Low $r_{DS(on)}$ provides higher efficiency and extends battery life
- Low thermal impedance copper leadframe SC70-3 saves board space
- Fast switching speed
- High performance trench technology

| PRODUCT SUMMARY | | |
|-----------------|--------------------------|-----------|
| V_{DS} (V) | $r_{DS(on)}$ (OHM) | I_D (A) |
| -30 | 0.112 @ $V_{GS} = -10V$ | -1.5 |
| | 0.172 @ $V_{GS} = -4.5V$ | -1.2 |



| ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ UNLESS OTHERWISE NOTED) | | | |
|---|----------------|--------------------|------------|
| Parameter | Symbol | Maximum | Units |
| Drain-Source Voltage | V_{DS} | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | |
| Continuous Drain Current ^a | I_D | $T_A = 25^\circ C$ | -1.5 |
| | | $T_A = 70^\circ C$ | -1.2 |
| Pulsed Drain Current ^b | I_{DM} | -2.5 | A |
| Continuous Source Current (Diode Conduction) ^a | I_S | ± 0.28 | A |
| Power Dissipation ^a | P_D | $T_A = 25^\circ C$ | 0.34 |
| | | $T_A = 70^\circ C$ | 0.22 |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | -55 to 150 | $^\circ C$ |

| THERMAL RESISTANCE RATINGS | | | |
|--|------------|----------------|-------|
| Parameter | Symbol | Maximum | Units |
| Maximum Junction-to-Ambient ^a | R_{THJA} | $t \leq 5$ sec | 375 |
| | | Steady-State | 430 |

Notes

- Surface Mounted on 1" x 1" FR4 Board.
- Pulse width limited by maximum junction temperature



| SPECIFICATIONS (T _A = 25°C UNLESS OTHERWISE NOTED) | | | | | | |
|---|---------------------|--|--------|-------|------|------|
| Parameter | Symbol | Test Conditions | Limits | | | Unit |
| | | | Min | Typ | Max | |
| Static | | | | | | |
| Gate-Threshold Voltage | V _{GS(th)} | V _{DS} = V _{GS} , I _D = -250 uA | -1 | | | V |
| Gate-Body Leakage | I _{GSS} | V _{DS} = 0 V, V _{GS} = ±20 V | | | ±100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = -24 V, V _{GS} = 0 V | | | -1 | uA |
| | | V _{DS} = -24 V, V _{GS} = 0 V, T _J = 55°C | | | -10 | |
| On-State Drain Current ^A | I _{D(on)} | V _{DS} = -5 V, V _{GS} = -10 V | -5 | | | A |
| Drain-Source On-Resistance ^A | r _{DS(on)} | V _{GS} = -10 V, I _D = -1.5 A | | | 112 | nΩ |
| | | V _{GS} = -4.5 V, I _D = -1.2 A | | | 172 | |
| Forward Transconductance ^A | g _s | V _{DS} = -5 V, I _D = -1.5 A | | 9 | | S |
| Diode Forward Voltage | V _{SD} | I _S = -0.46 A, V _{GS} = 0 V | | -0.65 | | V |
| Dynamic^b | | | | | | |
| Total Gate Charge | Q _g | V _{DS} = -10 V, V _{GS} = -5 V, I _D = -1.5 A | | 7.2 | | nC |
| Gate-Source Charge | Q _{gs} | | | 1.7 | | |
| Gate-Drain Charge | Q _{gd} | | | 1.5 | | |
| Turn-On Delay Time | t _{d(on)} | V _{DD} = -10 V, I _L = -1 A, V _{GEN} = -4.5 V, R _G = 6 Ω | | 10 | | ns |
| Rise Time | t _r | | | 9 | | |
| Turn-Off Delay Time | t _{d(off)} | | | 27 | | |
| Fall-Time | t _f | | | 11 | | |

Notes

- a. Pulse test: PW ≤ 300us duty cycle ≤ 2%.
- b. Guaranteed by design, not subject to production testing.
- c. Repetitive rating, pulse width limited by junction temperature.